

# Flash Memory: Key Signal Processing Issues

Jaekyun Moon

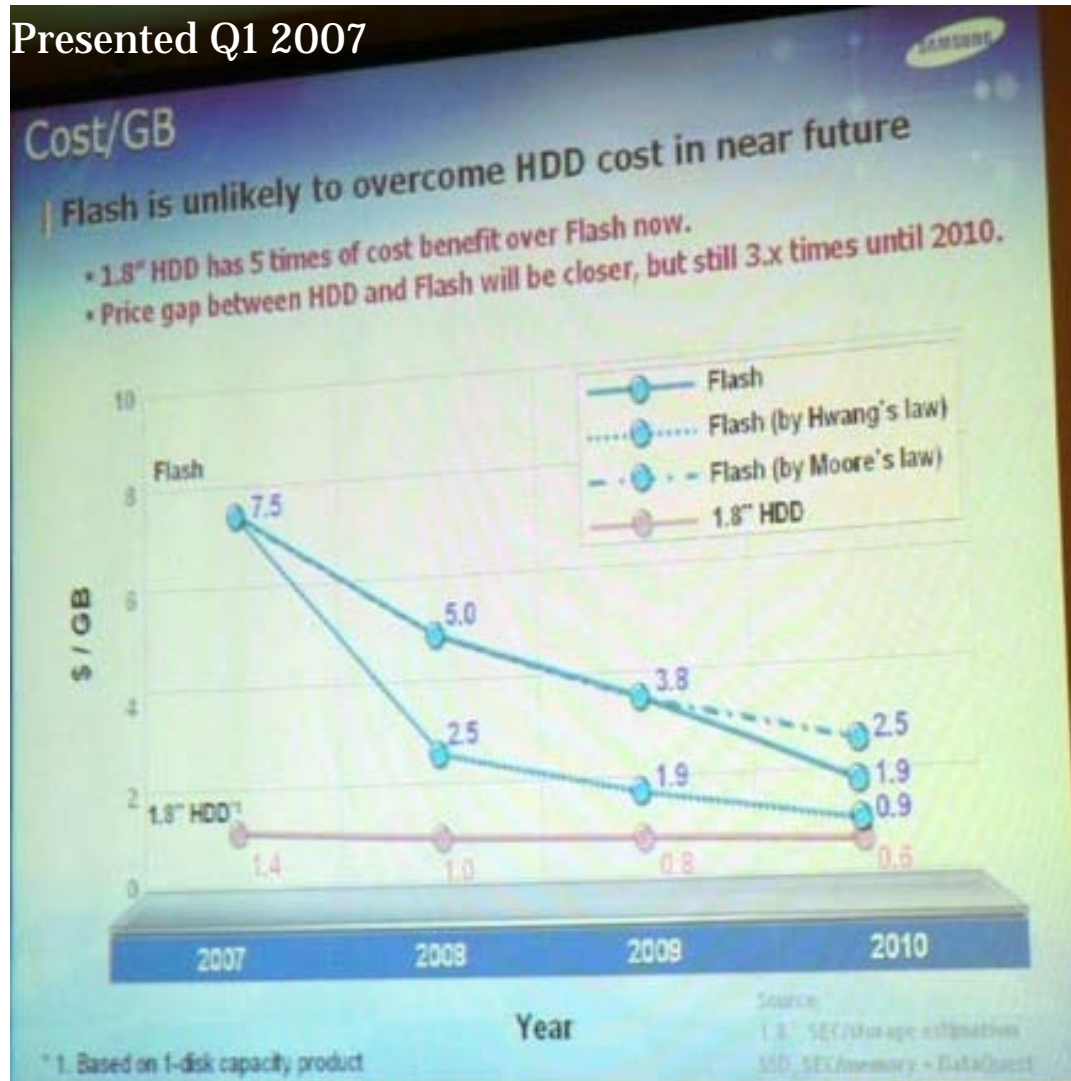
EE Dept  
KAIST

April 19, 2010

NVRAMOS Forum

# HDD vs SSD: Price Trend

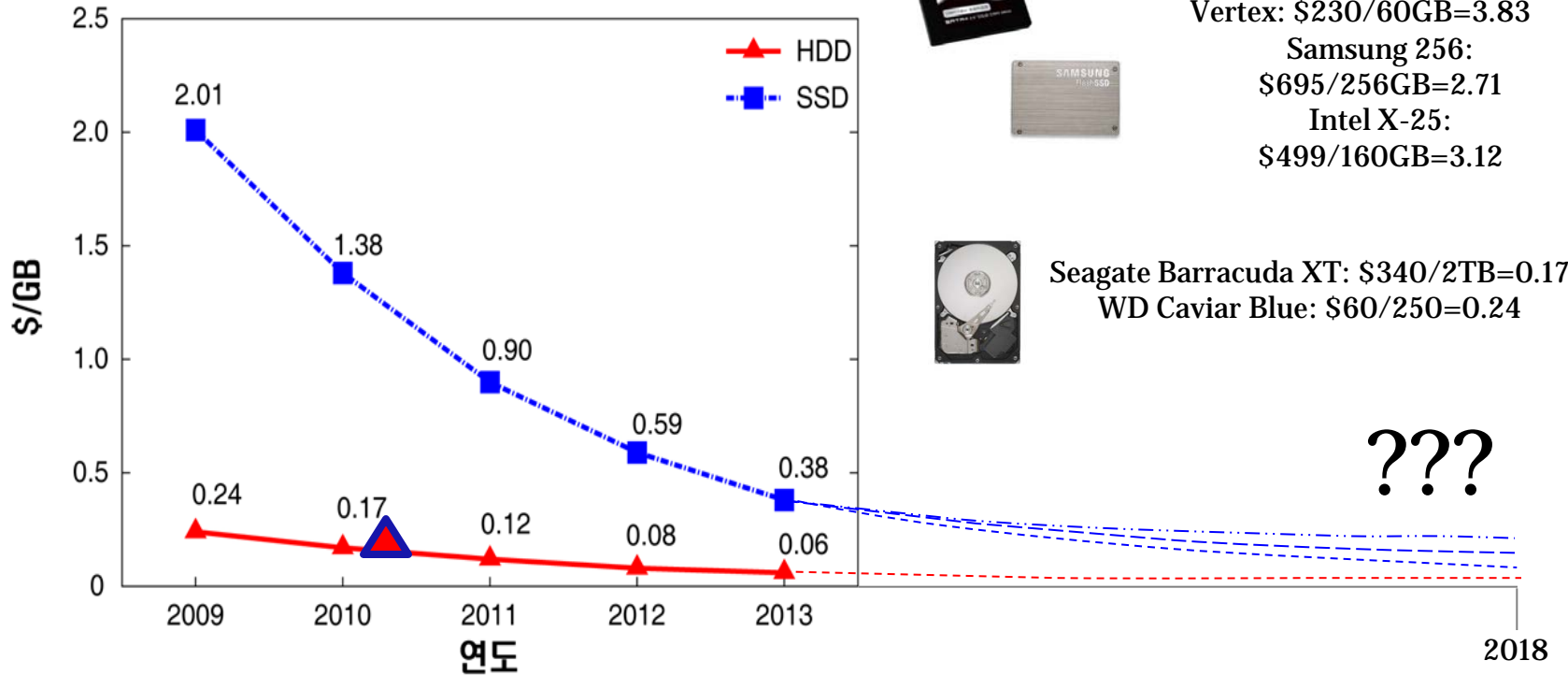
Presented Q1 2007



SSD prices were assumed to fall by about 60% annually.

# HDD vs SSD: Price Trend

HDD와 SSD 의 GB당 가격 비교



연도별 HDD와 SSD의 GB당 가격 비교 (출처: iSuppli)

# Home Storage Server



Home Storage Server



1TB NAS Server, 480/12 Mbps  
\$138.00

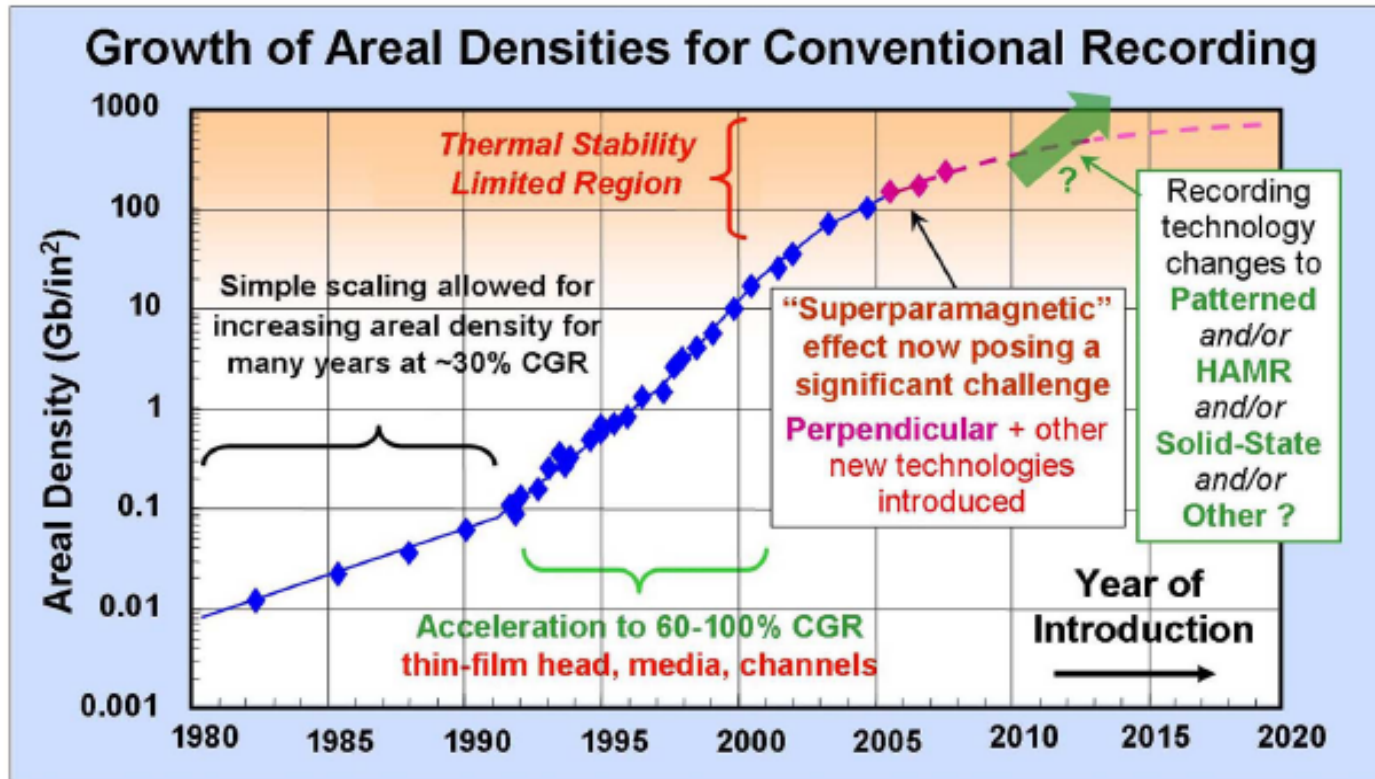
Price: \$0.14/GB

# Flash Memory in iPad

\$499 for 16G iPad versus \$699 for 64G iPad



# Sustaining Storage Density Growth...



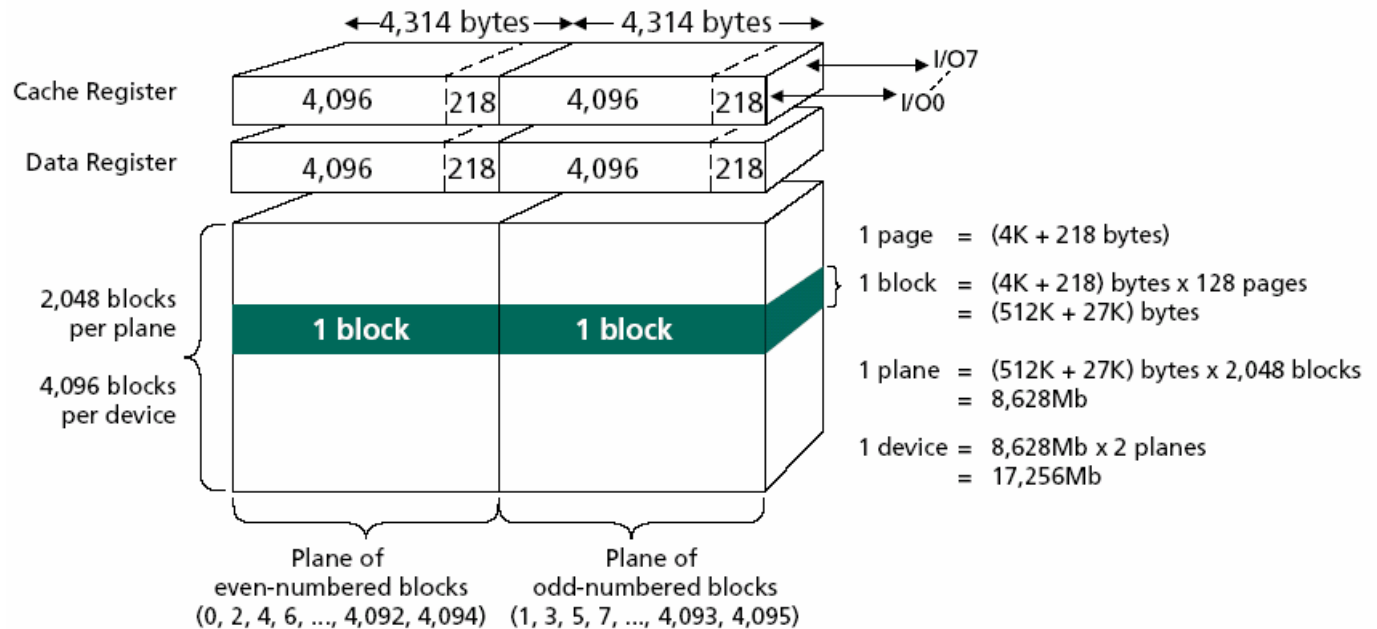
PROCEEDINGS OF THE IEEE | Vol 96, No. 11, November 2008

# Outline

- How many raw errors can we realistically correct using advanced SSP?
  - LDPC code versus BCH
- Essential Ingredients
  - Channel characterization (J. Moon)
  - Capacity-achieving coding (J.S. Ha)

# MLC NAND Flash Architecture

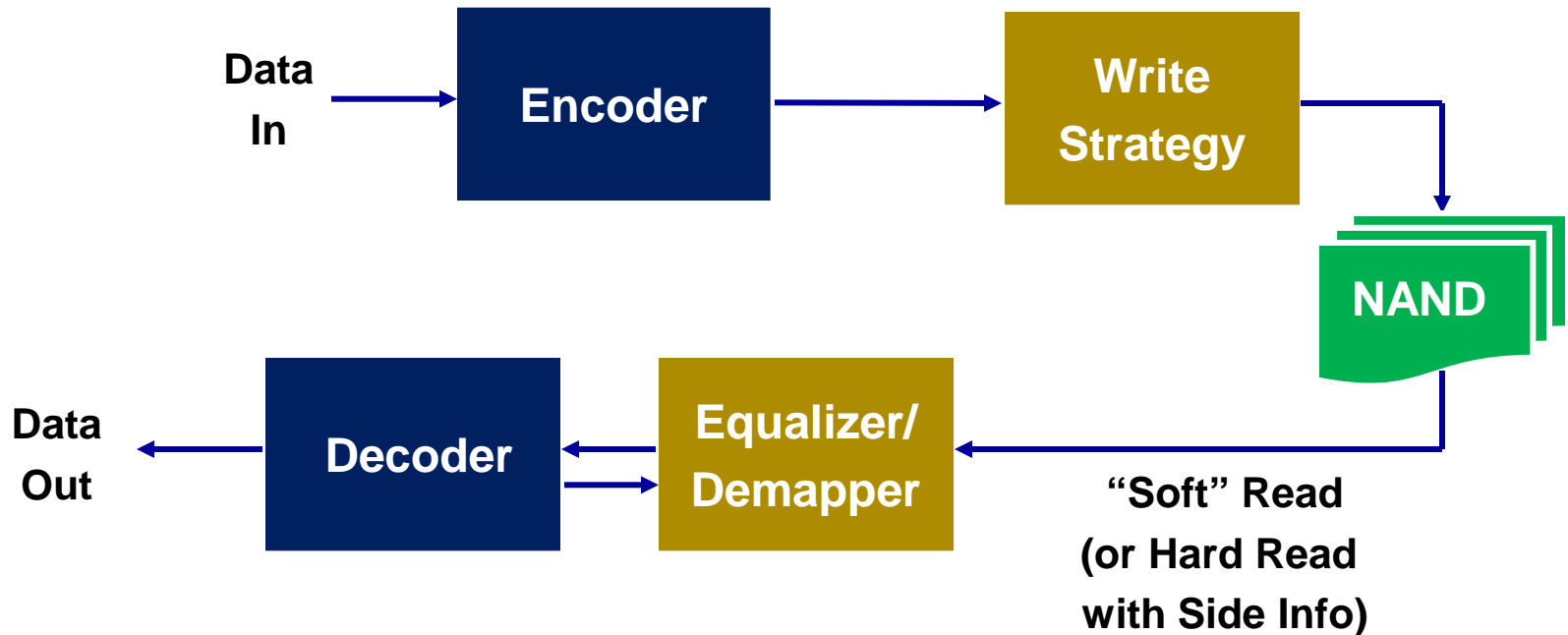
A 2-plane, 4K-page MLC architecture. The 4K page has 4,096 bytes of data and 218 bytes of spare area.



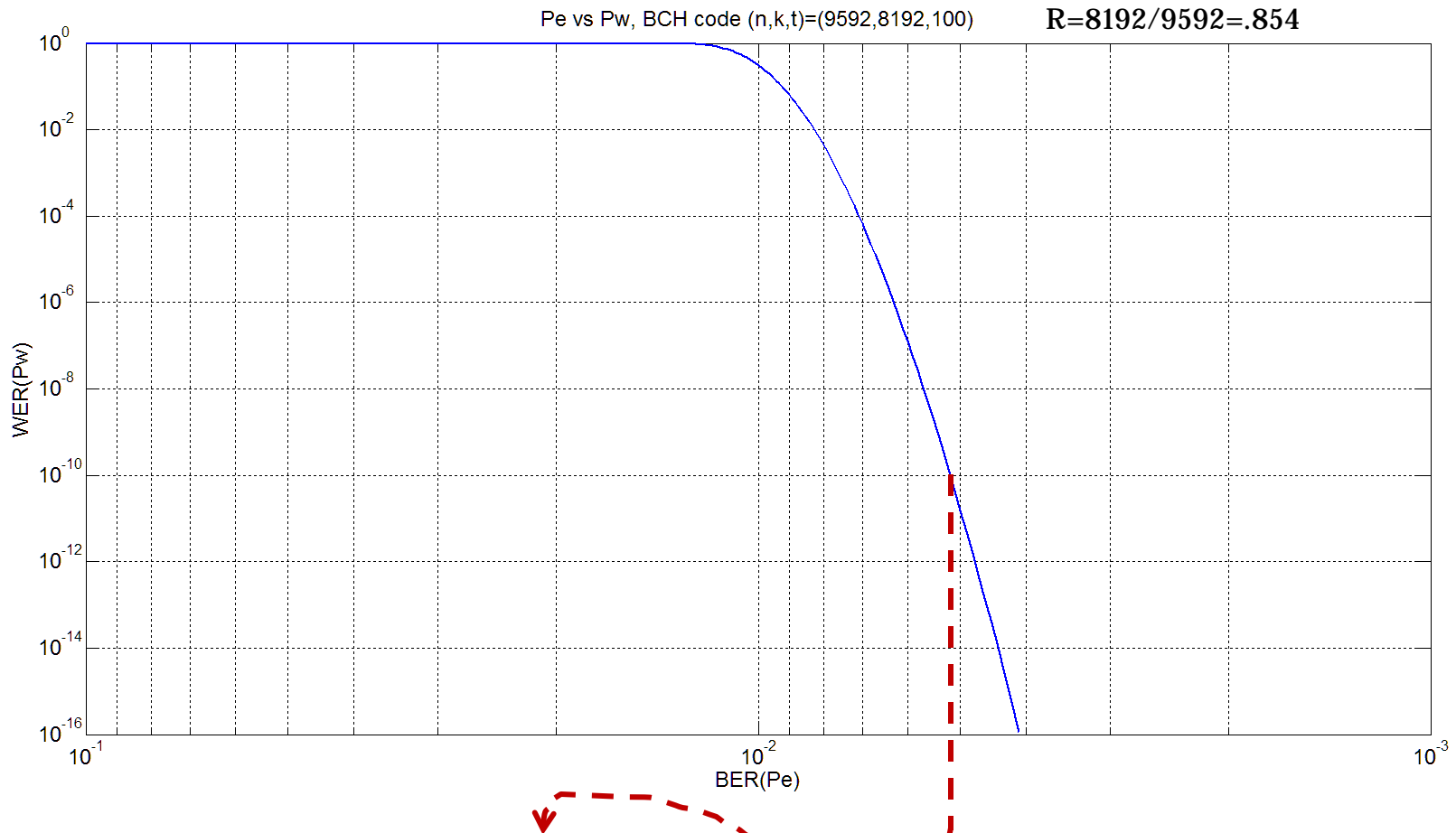
A 16Gb MLC NAND Flash Example



# SSP Signal Flow

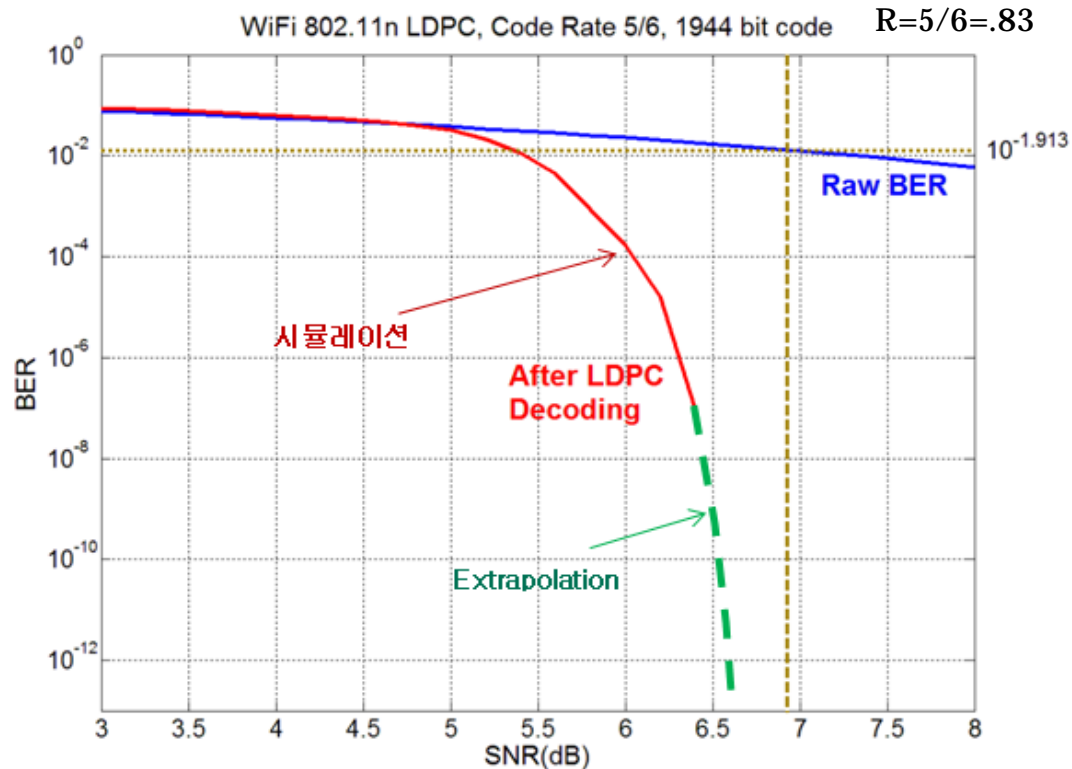


# BCH Code Performance: Raw BER vs Corrected WER



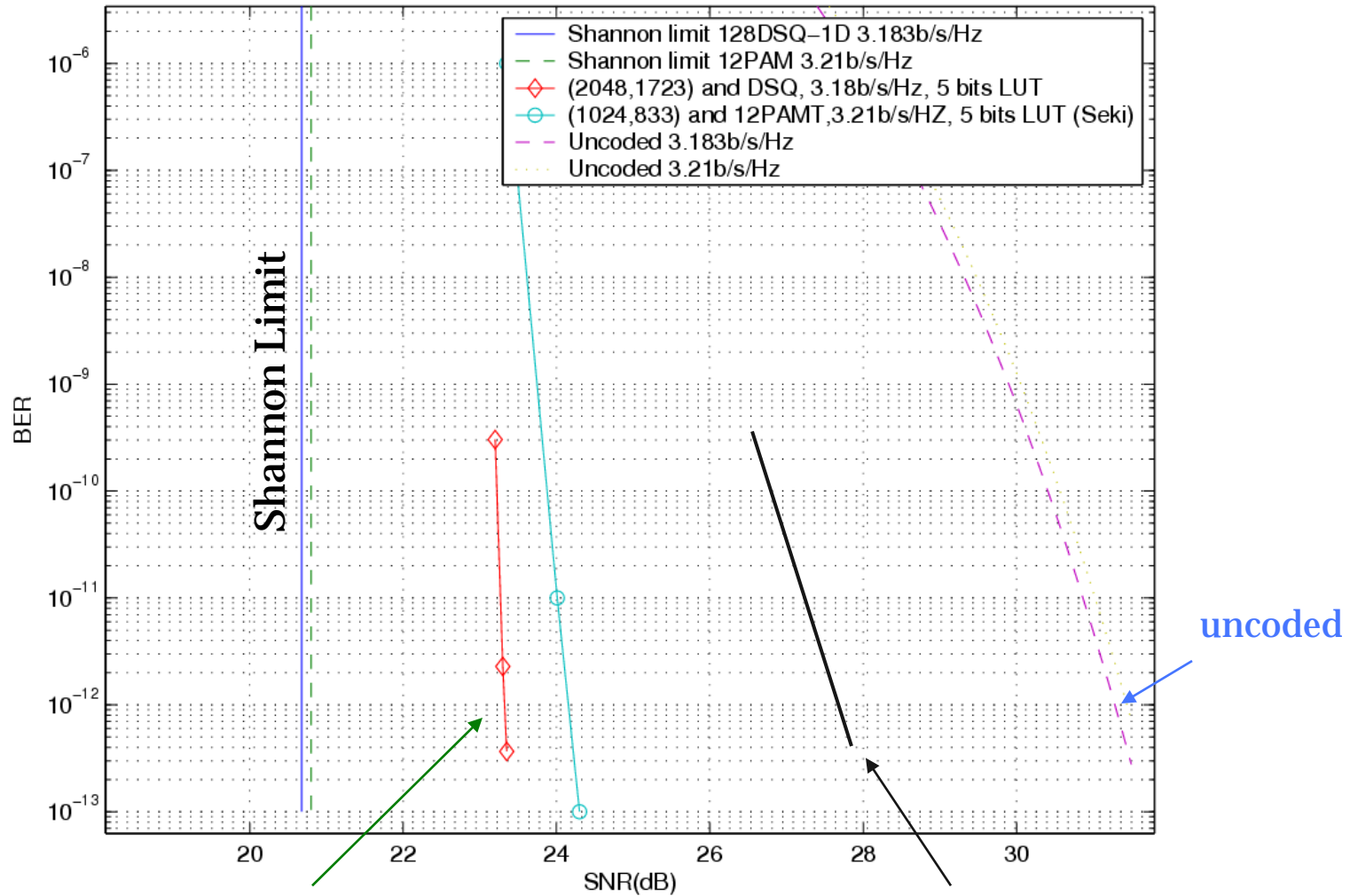
Need BER of  $\sim 5 \times 10^{-3}$  or lower  
to bring down WER to less than  $10^{-10}$ .  
Can handle less than 48 error bits on average per 9592 bits.

# LDPC Code Performance



LDPC can handle  $10^{(-1.913)} \times 9830 = 120$  error bits on average per 9830 bits  
(Probably ideal and optimistic).

Real LDPC Error performance (10G Ethernet) – no visible error floor (gives us hope!)



LDPC (2048,1723), R=0.84

BER with TCM (estimated)

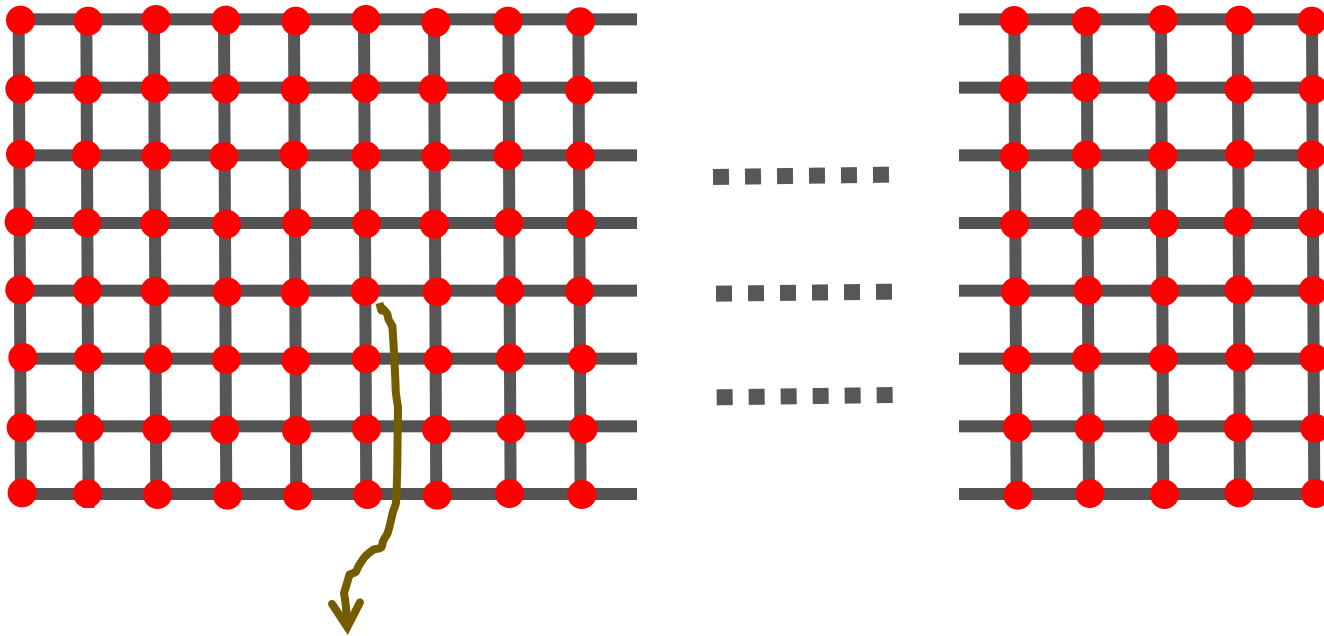
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# Essential Ingredients in Advanced SSP

- Accurate channel characterization
- Soft information generation and processing

# Channel Modeling: Signal-Level Characterization of Cell Correlation (Disturb)

# Channel Modeling: Cell Correlation

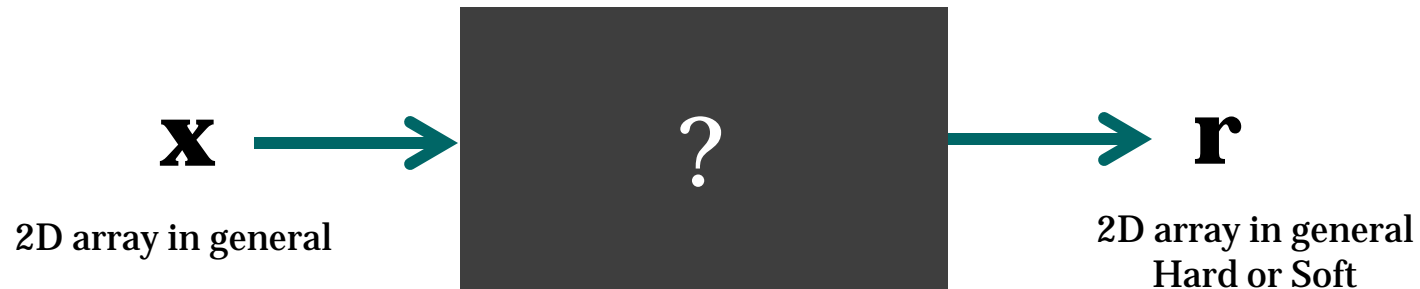


No cell correlation  $r_{ij} = x_{ij} + n_{ij}$

Cell correlation through program/read disturb  $r_{ij} = x_{ij} + \Delta(x_{ij}, \underbrace{x_{i_1 j_1}, x_{i_2 j_2}, x_{i_3 j_3}, x_{i_4 j_4}}_{\text{affecting cells}}) + n_k$

$\swarrow$   
 victim cell

# Channel Identification Problem

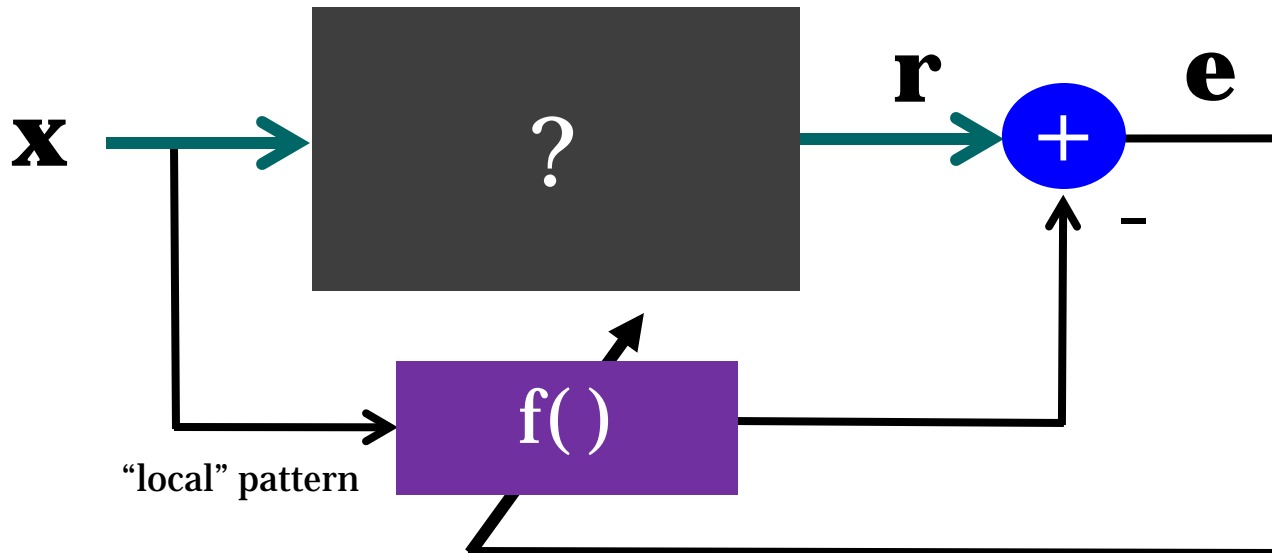


Feed the system with known data  $\mathbf{x}$ .  
Observe  $\mathbf{r}$ .

Characterize the system enough, so for new data  $\mathbf{x}'$   
we would know what  $\mathbf{r}'$  is.



# Channel Identification Problem



Feed the system with known data  $\mathbf{x}$ .

Adjust  $f()$  until  $\mathbf{e}$  is minimized (a sequential update algorithm is used).

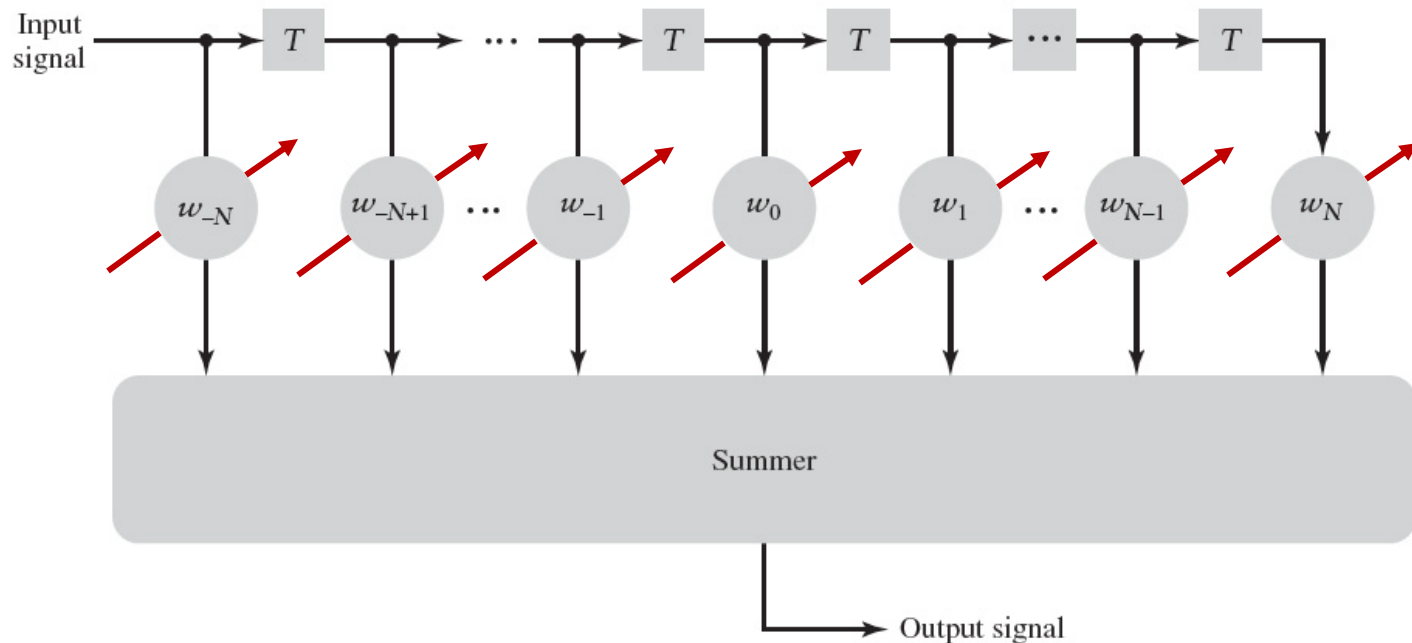
Once  $\mathbf{e}$  stabilizes,  $f()$  should resemble the system closely.

We in essence are fitting the unknown box with a partially unknown function (a certain structure is imposed)

# Characterized Channel

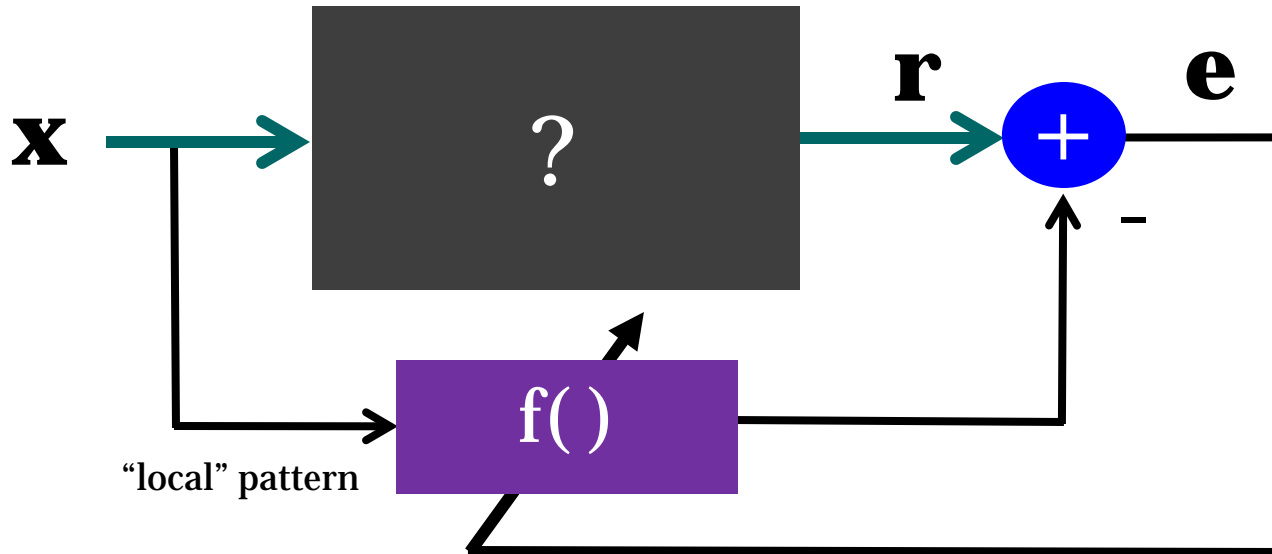


# Example of $f(\cdot)$ : Linear FIR Filter



Popular model for one dimensional inter-symbol interference

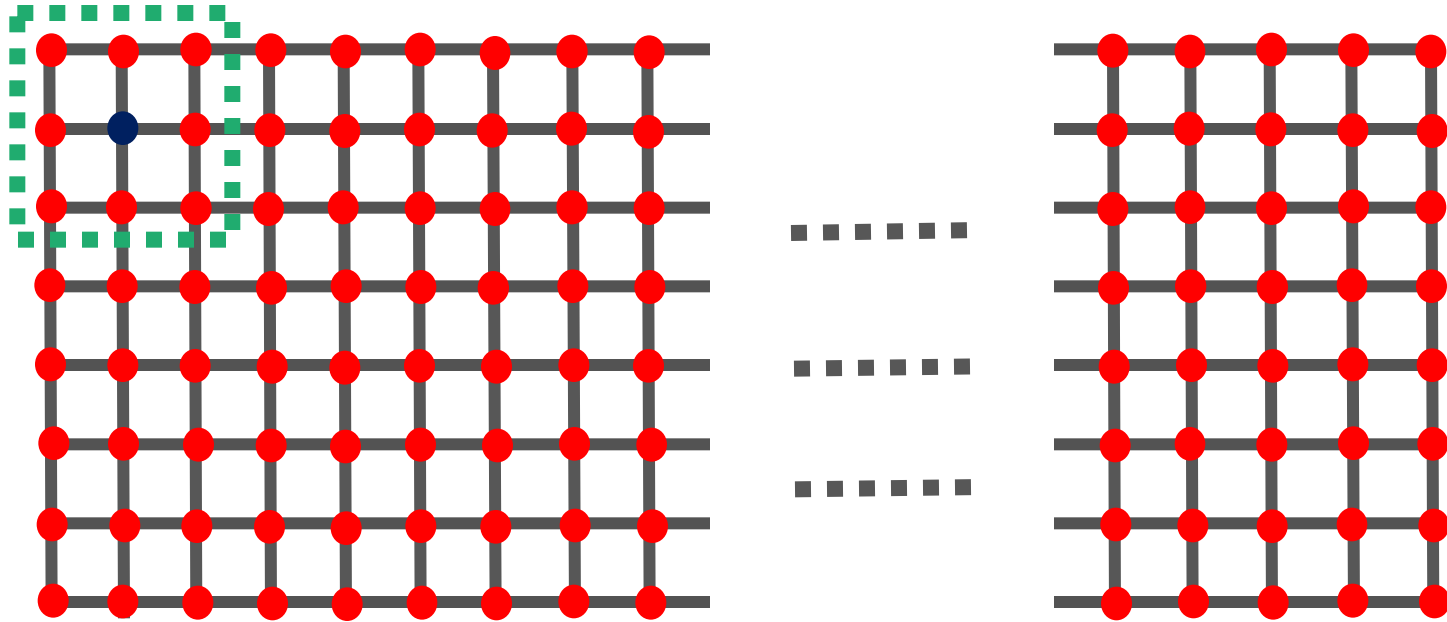
# A general $f()$ : RAM



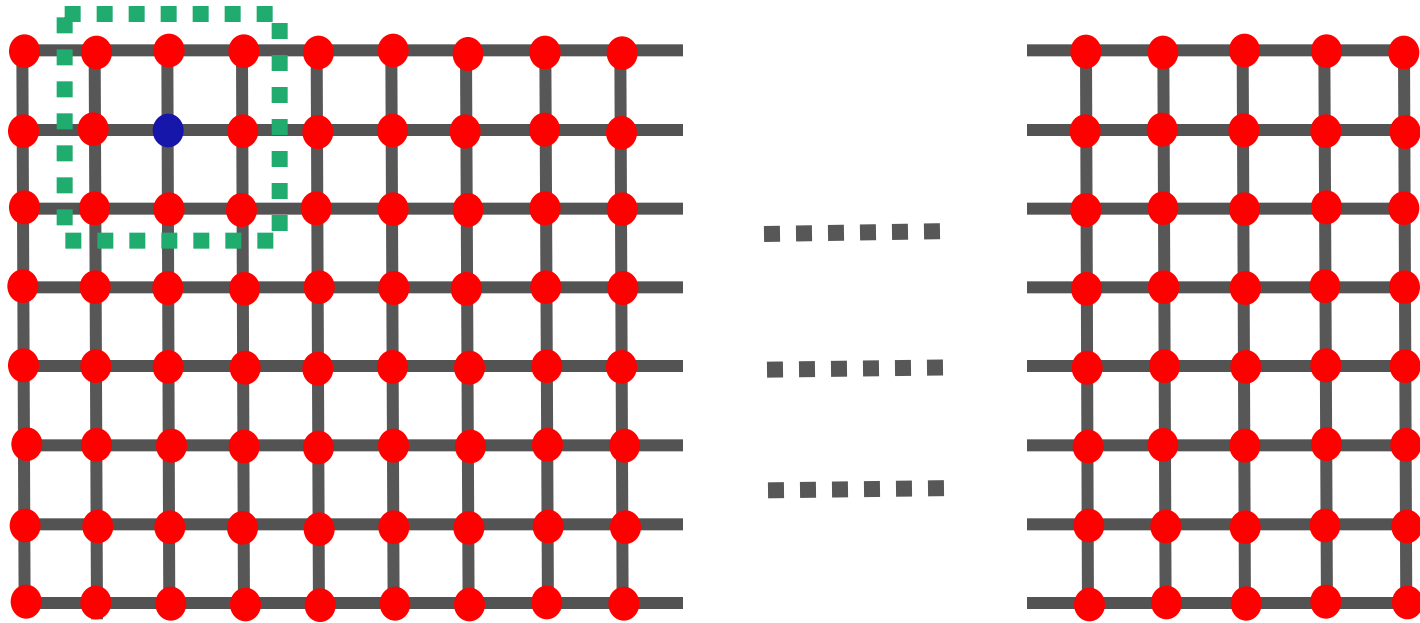
$f()$  is a RAM and its contents get updated in the direction to minimize  $\mathbf{e}$ . The write values of a cell and its affecting cells act as the pointer (address) to a particular location in the RAM. The RAM content is the read value of the victim cell.

After feeding the system and the model with a long data  $\mathbf{x}$ , all locations of the RAM will have been updated and stabilized.

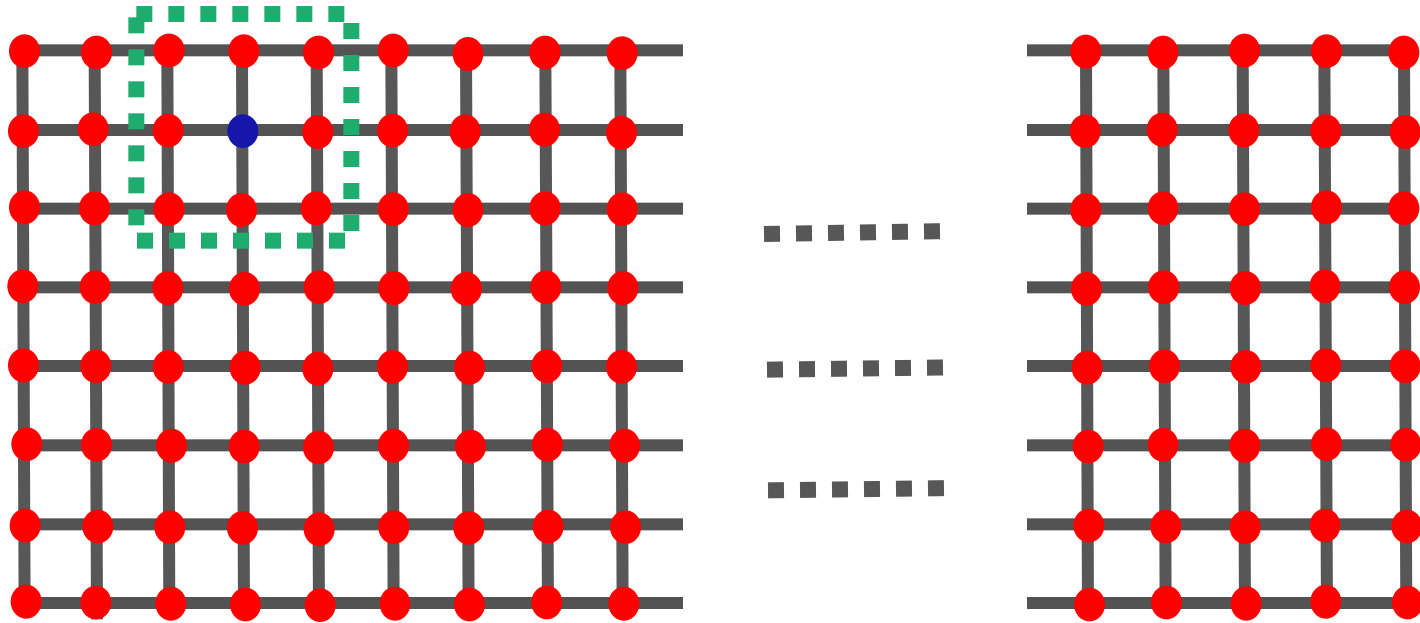
# RAM Update Process: An Example of “Local” Pattern



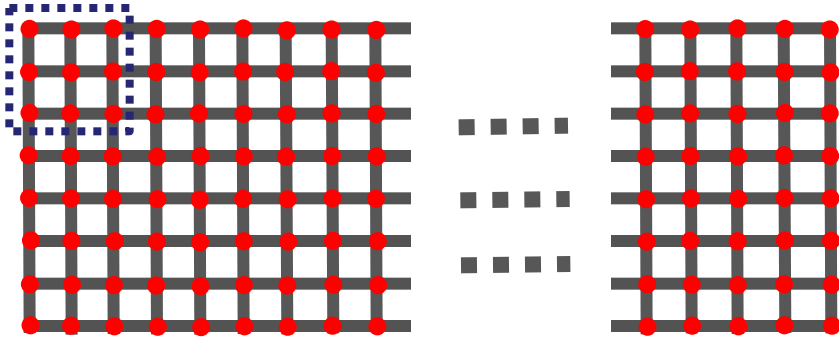
# RAM Update Process: An Example of “Local” Pattern



# RAM Update Process: An Example of “Local” Pattern

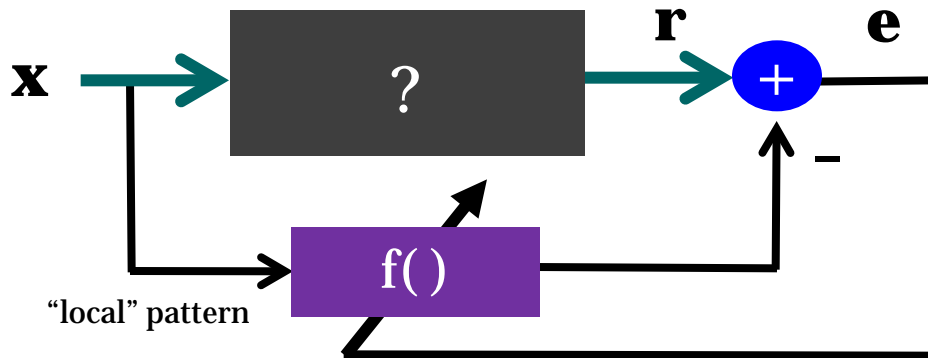


# RAM Update Process

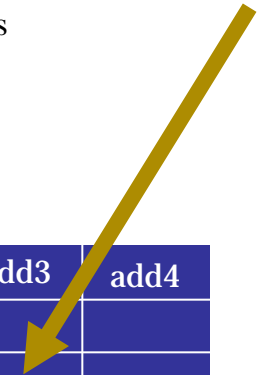


$$f \left( \underbrace{x_{ij}}_{\text{victim cell}}, \underbrace{x_{i,j-1}, x_{i-1,j}, x_{i,j+1}, x_{i+1,j}}_{\text{affecting cells}} \right) \approx r_{ij}$$

*address (surrounding pattern)*



add1	add2	add3	add4
add5	add6		

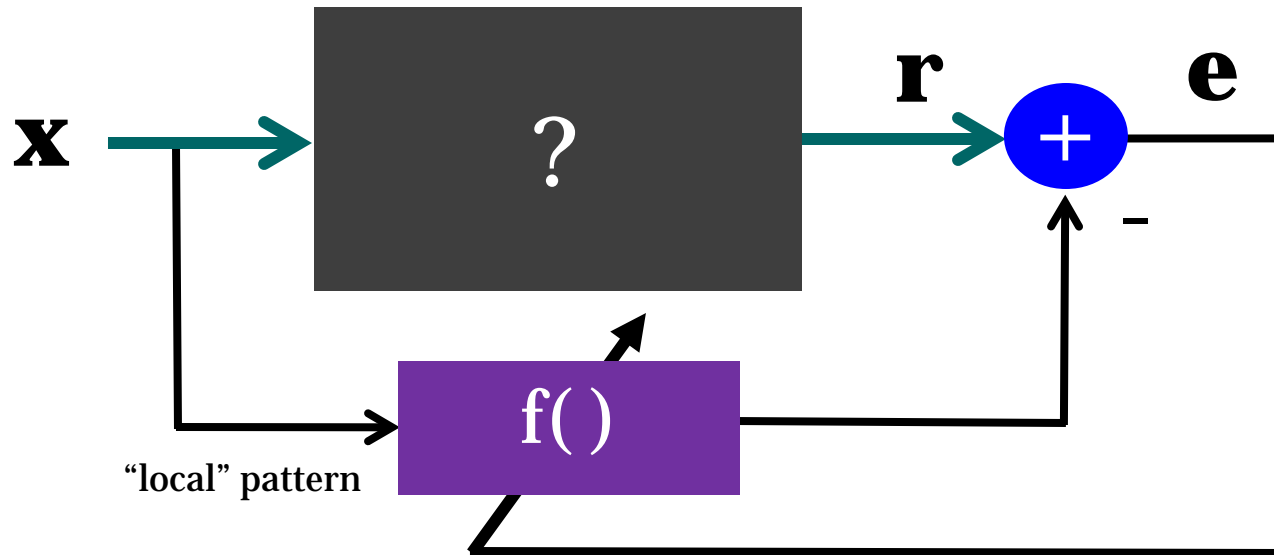


$$f(\text{address1}) \leftarrow f(\text{address1}) + \mu \cdot r(\text{address1}) \cdot e(\text{address1})$$

Do this for all addresses.



# A general $f(\cdot)$ : RAM



Assumption: correlation among a cell and its affecting cells is position-shift-invariant.

If  $x_k$  is affected by  $x_{k-1}$  and  $x_{k+1}$  in a certain way, then  $x_{k+1}$  will be affected by  $x_k$  and  $x_{k+2}$  in the same way.

# Some of the discussion points ...

- Are there such thing as the rough “local” pattern and can device people figure this out, if so?
  - Exact function can be obtained via statistical identification as described
- Feasibility of extracting soft information